

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10087699	CHENG ET AL.
Examiner	Art Unit	
David M Naff	1657	

SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES

Search Notes	Date	Examiner
West-see search history	5/22/08	DMN

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner